## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

New York, New York

Yoichi MOCHIDA

Date: July 5, 2001

Group Art Unit: ----

Serial No.: To Be Assigned

Examiner: -----

Filed: Herewith

For: EXTERNAL FORCE MEASURING DEVICE

**Assistant Commissioner for Patents** 

Washington, D.C. 20231

## INFORMATION DISCLOSURE STATEMENT

Sir:

Submitted herewith is a copy of art together with a form listing the same for the convenience of the Examiner.

## EXPRESS MAIL CERTIFICATE

I hereby certify that this correspondence is being deposited with the United States Postal Service as Express Mail Post Office to Addressee (mail label #EL613107673US) in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on July 5, 2001:

Tamika Sumpter

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Signature July 5, 2001

Date of Signature

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Respectfully submitted

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APPLICANT'S ART CITATION							Applicant Yoichi MOCHIDA							
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<sup>\*</sup> Abstracts only